



IEC QUALITY ASSESSMENT SYSTEM (IECQ)
 covering Electronic Components,
 Assemblies, Related Materials and Processes
 For rules and details of the IECQ visit www.iecq.org

Certificate of Approval Independent Testing Laboratory

IECQ Certificate No.:	IECQ-L NSAIUS 09.0005	Issue No.:	5	Status:	Current
Supersedes:	<u>IECQ-L NSAIUS 09.0005 Issue 4</u>	Issue Date:	2014/12/19	Org Issue:	2008/10/21
CB Certificate No.:	1.72.0031/B	Expiration:	2017/12/18		

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The organization, facilities and procedures have been assessed and found to comply with the applicable requirements for Independent Testing Laboratory organization approval, in support of the IECQ system, which is in accordance with the Basic Rules IECQ 01 and Rules of Procedure IECQ 03-6 "Independent Testing Laboratory Assessment Program Requirements" of the IEC Quality Assessment System for Electronic Components (IECQ) and applicable requirements of ISO/IEC 17025: 2005 for the testing of electronic components under the IECQ.

Scope:

Environmental and reliability testing, inspection and failure analysis (by standards of IEC 60068, MIL-STD-202, MIL-STD-810, MIL-STD-883, JESD-22 series, ANSI/ESD STM5.1/5.2/5.3, BELL Core GR-63, J-STD-020, AEC-Q100, AEC-Q101, IPC-TM-650, IPC-A-600, IPC-A-610, IPC-6012, J-STD-035, JESD201, EIAJ ED-4701),

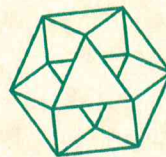
Including tests of:

Electrostatic discharge test (HBM/MM/CDM), External visual, Emission microscope, Focused Ion Beam, Highly Accelerated Temperature and Humidity Stress test, High Temperature Storage Life, Humidity storage, Latch-up, Low Temperature Storage Life, Micro section, Moisture Reflow Sensitivity Classification for Nonhermetic Solid State Surface Mount Devices, Preconditioning of Nonhermetic Surface Mount Device Prior To Reliability, Probe station, Accelerated Moisture Resistance Unbiased Autoclave(Pressure cook), Scanning electron microscope, Temperature and Humidity Bias Life, Temperature Bias and Operating Life, Temperature cycling, Thermal shock, Cycled Temperature Humidity Bias Life, Accelerated Moisture Resistance -Unbiased HAST.

Approved by Certification Body (CB): National Standards Authority of Ireland, Inc.

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 United States

Authorized person:
Kevin D Mullaney



NSAI

Sponsoring Member Body



The validity of this approval is maintained through on-going surveillance inspections.
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